

BQ25616, BQ25616J BMS026 Evaluation Module

This user's guide provides detailed testing instructions for the BQ25616 and BQ25616J evaluation modules (EVM). Also included are descriptions of the necessary equipment, equipment setup, and procedures. The reference documentation also contains the printed-circuit board layouts, schematics, and the bill of materials (BOM).

Throughout this user's guide, the abbreviations *EVM*, *BQ25616EVM*, *BQ25616JEVM*, *BMS026*, and the term *evaluation module* are synonymous with the BMS026 evaluation module, unless otherwise noted.

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1 Introduction

1.1 EVM Features

For detailed features and operation, refer to [Table 1](#) for a list of devices and their data sheets.

Table 1. Device Data Sheets

Device	Data Sheet	EVM Label	Variant
BQ25616	SLUSDF7	BQ25616EVM	001
BQ25616J	SLUSDF7	BQ25616JEVM	002

The BMS026 evaluation module (EVM) is a complete charger module for evaluating the standalone single-cell NVDC charger using any of the devices above.

This EVM features adjustable input current limit, charging current, and charging voltage. It also has the ability to test the D+/D- input source type detection, external input over-voltage protection, and simulate battery high and low temperature conditions.

1.2 I/O Descriptions

[Table 2](#) lists the input and output connections available on this EVM and their respective descriptions.

Table 2. EVM I/O Connections

Jack	Description
J1(2) – VAC	Positive rail of the charger input voltage
J1(1) – GND	Ground
J2(1) – SYSTEM	Positive rail of the charger system output voltage, typically connected to the system load
J2(2) – GND	Ground
J3(1) – PMID	Positive rail of the charger output voltage for power bank applications in reverse boost mode (OTG). This output also shares the rail with the VIN input rail in forward buck mode
J3(2) – GND	Ground
J4	Input source Micro B USB port
J5-BATSNS_ICHG	BATSNS or ICHG pin connection
J5(3) – ICHG	ICHG pin external connection
J5(2) – BATTERY	Positive rail of the charger battery input, connected to the positive terminal of the external battery
J5(1) – GND	Ground
J6	USB2ANY 10-pin connector
J7	I2C 4-pin connector for the EV2300/2400 interface board

[Table 3](#) lists the jumpr, shunt and switch installations available on this EVM and their respective descriptions.

Table 3. EVM Jumper, Shunt and Switch Installation

Jack	Description	BQ25616 Setting	BQ25616J Setting
JP1	VBUS additional capacitance connection	Not Installed	Not Installed
JP2	SYS additional capacitance connection	Not Installed	Not Installed
JP3	PMID additional capacitance connection	Not Installed	Not Installed
JP4	BAT additional capacitance connection	Not Installed	Not Installed
JP5	I/O Pullup rail selection. Selection will have either BAT or SYS as the pullup rail for /CE, STAT, OTG, and /PG pins	Short PULLUP to SYS	Short PULLUP to SYS

Table 3. EVM Jumper, Shunt and Switch Installation (continued)

Jack	Description	BQ25616 Setting	BQ25616J Setting
JP6	Micro B USB input D+ connection to charger D+ pin	Installed	Installed
JP7	ICHG to BAT or BATTERY connection	Not Installed	Not Installed
JP8	ICHG resistor setting connection. Must be connected for charging to operate correctly.	Installed	Installed
JP9	Micro B USB input D+ connection to charger D+ pin	Installed	Installed
JP10	PSEL pin input current selection. Connect this to HIGH on PSEL enabled chargers to select 500mA default input current limit. Connect this to LOW on PSEL enabled chargers to select 2.4-A default input current limit	Not Installed	Not Installed
JP11	REGN connection to TS network. Must be connected for thermistor sensing to operate correctly.	Installed	Installed
JP12	ILIM resistor setting connection. Must be connected for 'Unknown Adapter' input current limiting to operate correctly.	Installed	Installed
JP13	STAT pin LED indicator connection. This indicates the current charger Status	Installed	Installed
JP14	/PG pin LED indicator connection. On /PG enabled chargers, this indicates the Power Good status	Installed	Installed
JP15	ICHG, ILIM, AGND header connection point.	Not Installed	Not Installed
JP16	Thermistor NORMAL temperature setting. Connect jumper to simulate charger entering TNORMAL (T2-T3) temperature region.	Installed	Installed
JP17	/CE pin connection to ground to enable charging. When removed, /CE pin will pull up to disable charge	Installed	Installed
JP18	Thermistor HOT temperature setting. Connect jumper to simulate charger entering THOT (>T5) temperature region.	Not Installed	Not Installed
JP19	D- to /PG rail connection	Not Installed	Not Installed
JP20	OTG pin connection to ground to disable OTG boost mode. When removed, OTG boost mode is enabled only in battery-only operation	Installed	Installed
JP21	VSET pin setting connection. Leave floating to set VBATREG to 4.208V. Connect to 10-kOhm to ground to set VBATREG to 4.100V. Connect to ground directly to set VBATREG to 4.352V	Not Installed	Not Installed
S1	/QON pin pull-down. No function.	Not Populated	Not Populated
S2	STAT and /PG LED bypass switches	1-4: Open, 2-3: Open	1-4: Open, 2-3: Open

Table 4 lists the recommended operating conditions for this EVM.

Table 4. Recommended Operating Conditions

Symbol	Description	MIN	TYP	MAX	Unit
V_{VBUS}, V_{VAC}	Input voltage applied to VAC and VBUS pins	4.0		13.5	V
V_{BAT}	Battery voltage applied to BAT pin			4.35	V
I_{VBUS}	Input current into VBUS			3.2	A
I_{SW}	Output current (SW)			3.2	A
I_{BAT}	Fast charging current			3.0	A
	RMS Discharging current through internal BATTET			6.0	A

2 Test Summary

2.1 Equipment

This section includes a list of supplies required for testing this EVM.

1. **Power Supplies:** Power supply #1 (PS1): A power supply capable of supplying 5 V at 3 A is required. While this part can handle larger voltage and current, it is not necessary for this procedure.
2. **Loads:** Load #1 (4-Quadrant Supply, Constant Voltage < 4.5 V): A "Kepco" Load, BOP, 20-5M, DC 0 to ± 20 V, 0 to ± 5 A (or higher)
Alternative Option: A 0-20V/0-5A >30-W DC electronic load set in a constant voltage loading mode.
 Load #2 (Electronic or Resistive Load): 10 Ω , 5 W (or higher)
3. **Meters:** (6x) "Fluke 75" multi-meters, (equivalent or better).
Alternative Option: (4x) equivalent voltage meters and (2x) equivalent current meters. The current meters must be capable of measuring at least 5-A.

2.2 Equipment Setup

Use the following instructions to set up the equipment:

1. Review EVM connections in [Table 2](#).
2. Set PS1 for 5-V DC, 3-A current limit and then turn off the supply.
3. Connect the output of PS1 in series with a current meter to J1 (VAC and GND).
4. Connect a voltage meter across TP7 (VBUS) and TP25 (PGND), or across J1.
5. Turn on Load #1, set to constant voltage mode, and output to 3.7-V. Disable Load. Connect Load in series with a current meter (multimeter), ground side, to J5 (BATTERY and GND) as shown in [Figure 1](#).
6. Connect one voltage meter across TP15 (BAT) and TP24 (PGND), or across J4-2 and J4-1 as shown in [Figure 1](#).
7. Connect one voltage meter across TP14 (SYS) and TP24 (PGND), or across J2-1 and J2-2 as shown in [Figure 1](#).
8. Install shunts as shown in [Table 3](#).

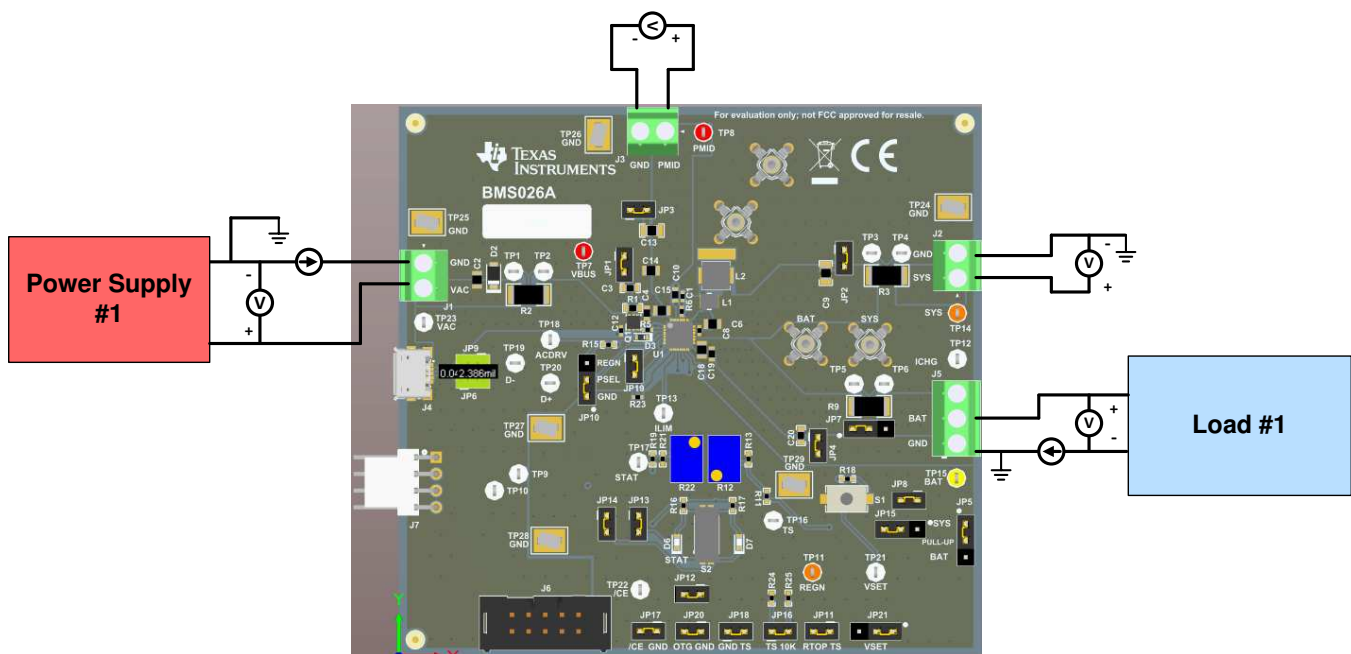


Figure 1. Original Test Setup for BMS026 EVM

2.3 Test Procedure

2.3.1 Initial Settings

1. Ensure [Section 2.2](#) steps have been followed.
2. Adjust R22 potentiometer to increase input current limit to the maximum value. To do this, turn R22 clockwise until a click is heard.
3. Turn on PS1
 - Measure → VSYS (SYS-TP14 and PGND-TP24) = 4.20V±0.3V

NOTE: Completely disconnect Load #1 from BAT pin if different voltage value is seen.

2.3.2 Charge Mode Verification

1. PS1 should be on from [Section 2.3.1](#).
2. Enable Load #1.
3. Adjust R12 potentiometer to increase the charge current limit to 1A
 - Measure → IBAT (current into Load #1) = 1.0A±25mA
 - Record IBAT measurement
4. Change Load #1 to 2.5V
 - Measure → VSYS (SYS-TP14 and PGND-TP24) = 3.65V±0.3V
 - Measure → IBAT (current into Load #1) = 5% of previous IBAT result ≈ 50mA±15mA

2.3.3 Boost Mode Verification

1. Turn off and disconnect PS1.
2. Set Load #1 to 3.7V and 2A current limit.

NOTE: If Load #1 connected from BATTERY-J5(2) to PGND-J5(1) is not a four quadrant supply, remove Load #1 and use PS1 (disconnected previously), set to 3.7V, 2A current limit and connect across BATTERY-J5(2) to PGND-J5(1).

3. Remove shunt JP20 to enable boost mode.
4. Connect Load #2 across VAC-J1(2) and GND-J1(1).
 - Measure → VBUS (VBUS-TP7 and PGND-TP25) = 5.0V±0.2V
5. Turn off and disconnect power supply.
6. Remove Load #2 from connection.
7. Reconnect shunt JP20.

2.3.4 Helpful Tips

- The leads and cables to the various power supplies, batteries and loads have resistance. The current meters also have series resistance. The charger dynamically reduces charge current depending on the voltage sensed at its VAC/VBUS pin (using the VINDPM feature), BAT pin (as part of normal termination), and TS pin (through its battery temperature monitoring feature via battery thermistor). Therefore, voltmeters must be used to measure the voltage as close to the IC pins as possible instead of relying on the digital readouts of the power supply. If a battery thermistor is not available, make sure shunt jp16 is in place.
- When using a source meter that can source and sink current as your battery simulator, TI highly recommends adding a large (1000+ μF) capacitor at the EVM BATTERY and GND connectors in order to prevent oscillations at the BAT pin due to mismatched impedances of the charger output and source meter input within their respective regulation loop bandwidths. Configuring the source meter for 4-wire sensing eliminates the need for a separate voltmeter to

measure the voltage at the BAT pin. When using 4-wire sensing, always ensure that the sensing leads are connected in order to prevent accidental overvoltage by the power leads

- For precise measurements of input and output currents, especially battery charging current regulation near termination, the current meter in series with the battery or battery simulator should not be set to auto-range and may need be removed entirely. An alternate method for measuring charge current is to either use an oscilloscope with hall effect current probe or by a differential voltage measurement across the relevant sensing resistors populated on the BMS026 EVM.

3 PCB Layout Guideline

Minimize the switching node rise and fall times for minimum switching loss. Proper layout of the components minimizing high-frequency current path loop is important to prevent electrical and magnetic field radiation and high-frequency resonant problems. This PCB layout priority list must be followed in the order presented for proper layout:

1. Place the input capacitor as close as possible to the PMID pin and PGND pin connections and use the shortest copper trace connection or PGND plane.
2. Place the inductor input terminal as close to the SW pin as possible. Minimize the copper area of this trace to lower electrical and magnetic field radiation but make the trace wide enough to carry the charging current. Do not use multiple layers in parallel for this connection. Minimize parasitic capacitance from this area to any other trace or plane.
3. Put an output capacitor near to the inductor and the IC. Tie ground connections to the IC ground with a short copper trace connection or PGND plane.
4. Route and connect analog ground (AGND) separately from the power ground (PGND). Connect AGND and PGND together using a power pad as the single ground connection point or use a 0- Ω resistor to tie.
5. Use a single ground connection to tie PGND to the charger ANGD just beneath the IC. Use ground copper pour but avoid power pins to reduce inductive and capacitive noise coupling.
6. Place decoupling capacitors next to the IC pins and make the trace connection as short as possible.
7. It is critical that the exposed power pad on the backside of the IC package be soldered to the PCB ground. Ensure that there are sufficient thermal vias directly under the IC connecting to the ground plane on the other layers.
8. The via size and number should be enough for a given current path.

See the EVM design for the recommended component placement with trace and via locations. For the QFN information, see [Quad Flatpack No-Lead Logic Packages](#) and [QFN/SON PCB Attachment](#).

4 Board Layout

Figure 2 through Figure 9 show the EVM PCB layout images.

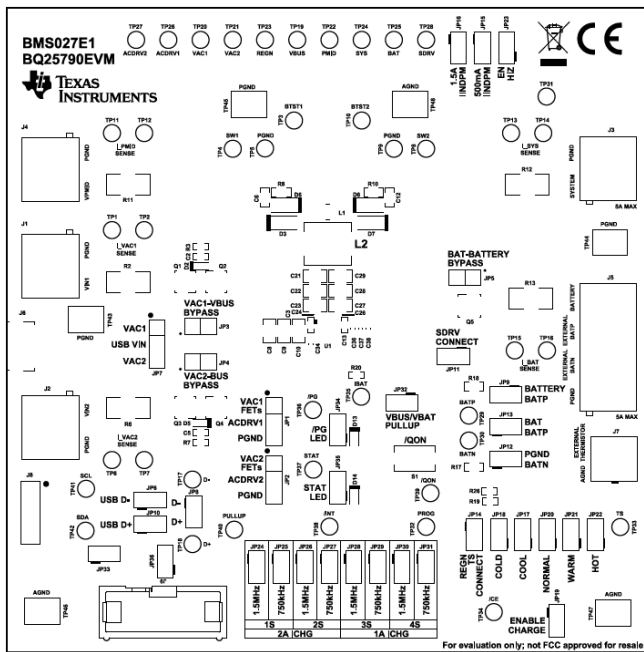


Figure 2. BMS026 EVM Top Overlay

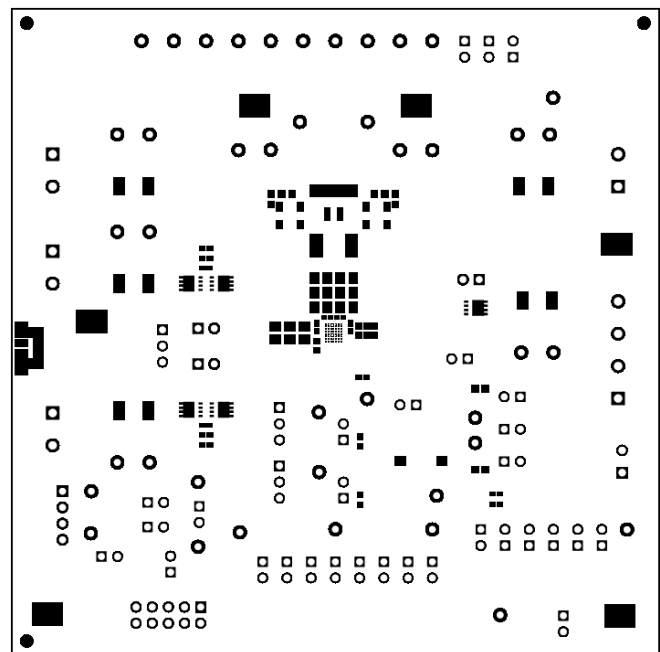


Figure 3. BMS026 EVM Top Solder Mask

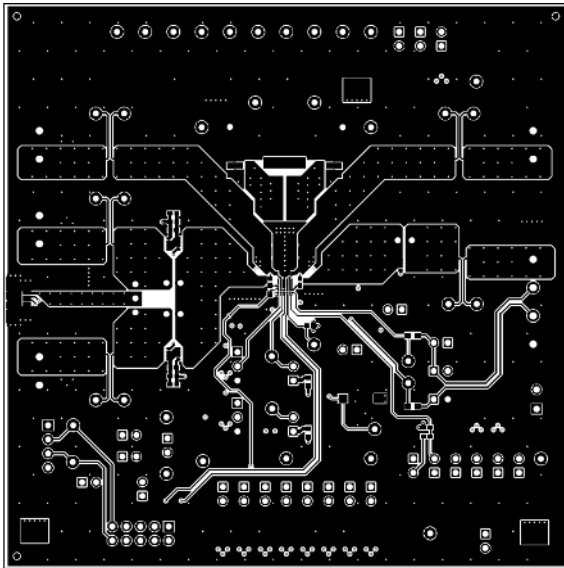


Figure 4. BMS026 EVM Top Layer

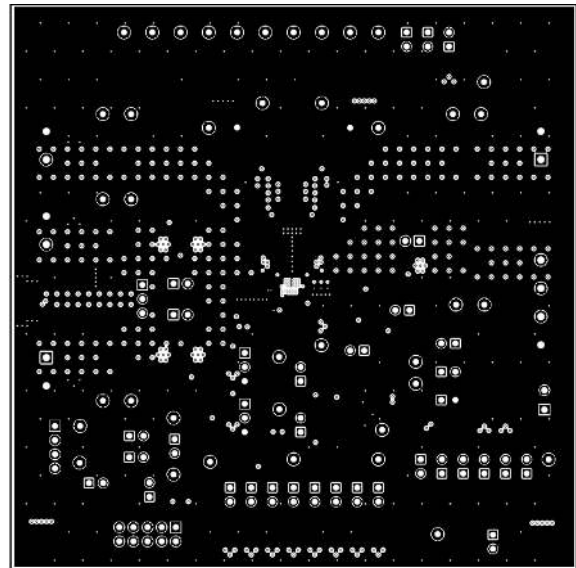


Figure 5. BMS026 EVM Signal Layer 1

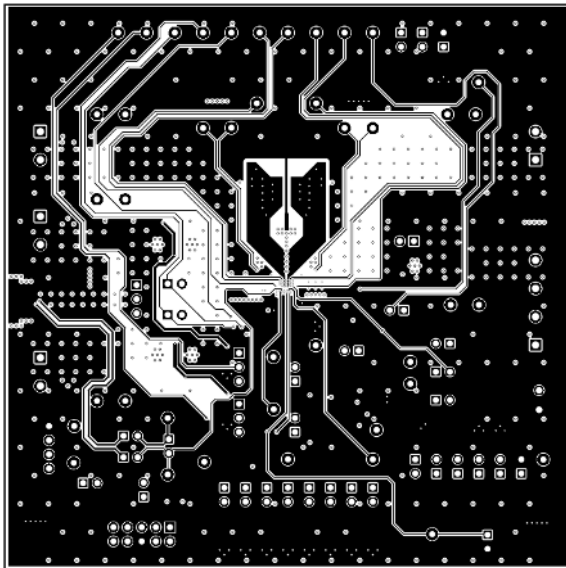


Figure 6. BMS026 EVM Signal Layer 2

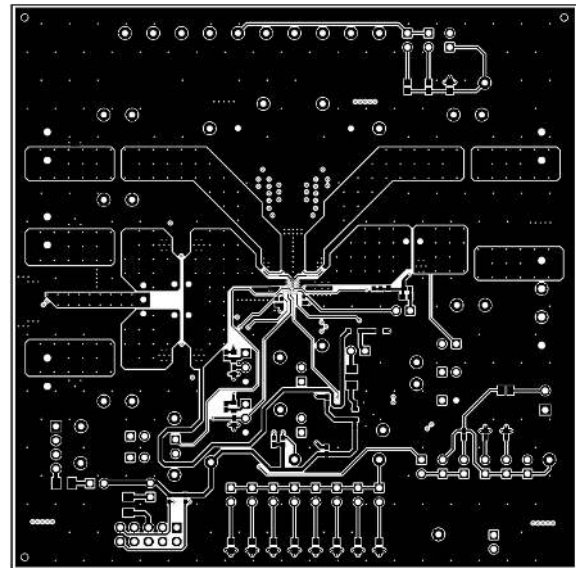


Figure 7. BMS026 EVM Bottom Layer

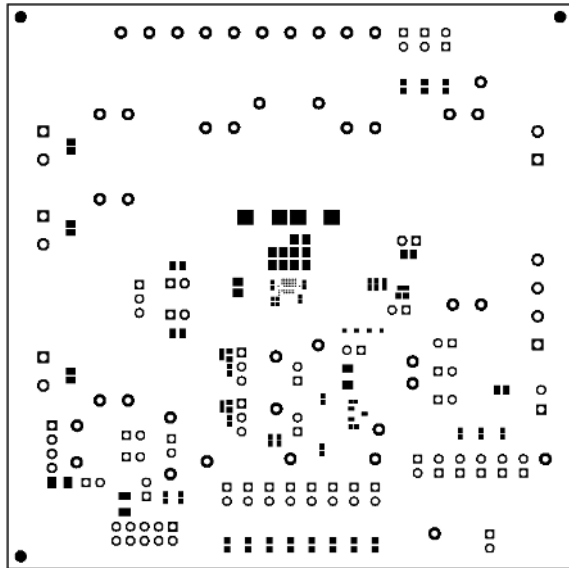


Figure 8. BMS026 Bottom Solder Mask

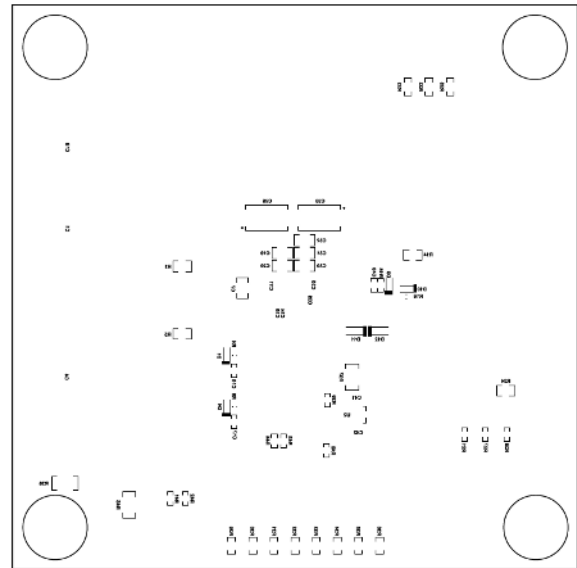


Figure 9. BMS026 Bottom Overlay

5 Schematic

Figure 10 shows the schematic for the BQ25616EVM.

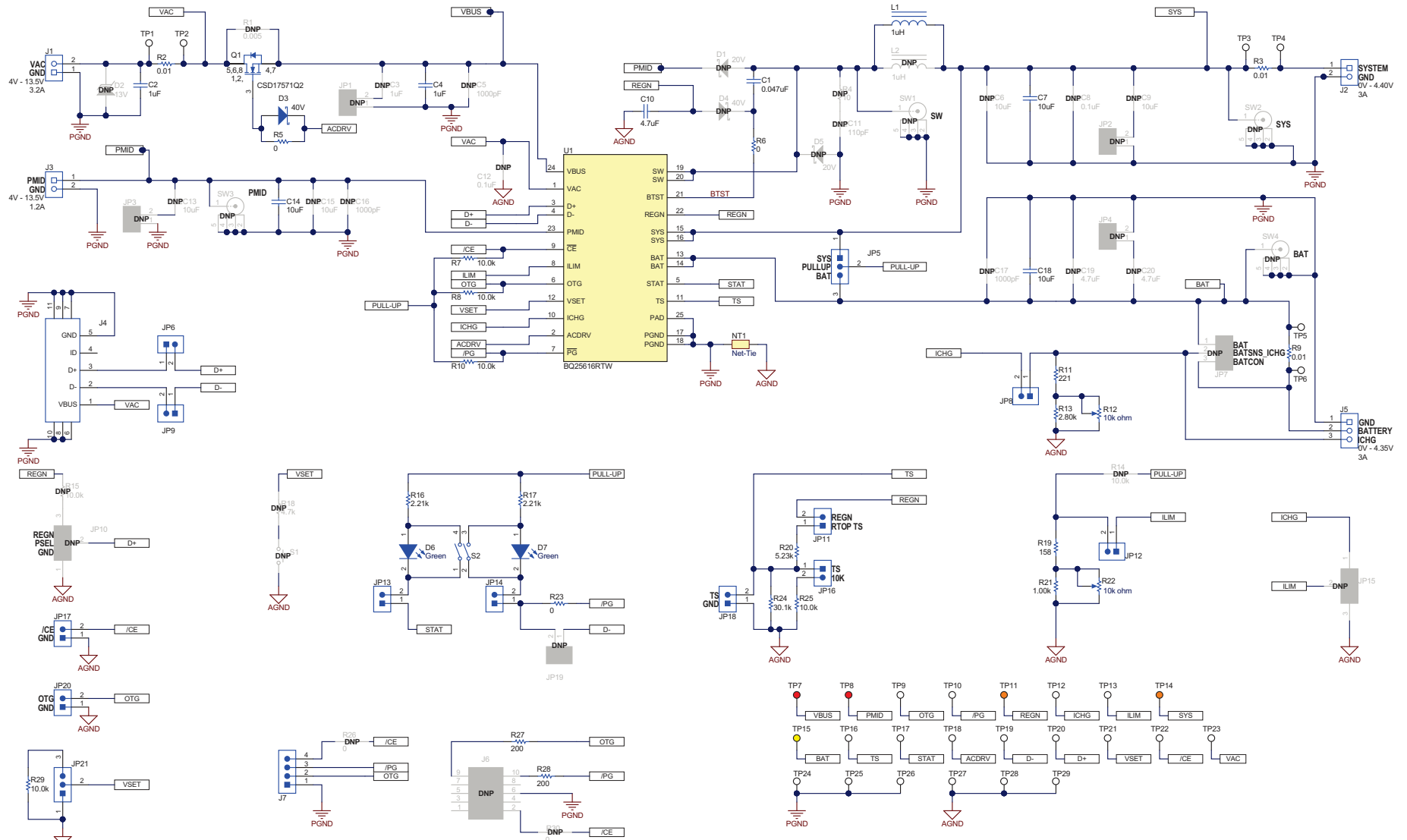


Figure 10. BQ25616EVM Schematic

Figure 11 shows the schematic for the BQ25616JEVM

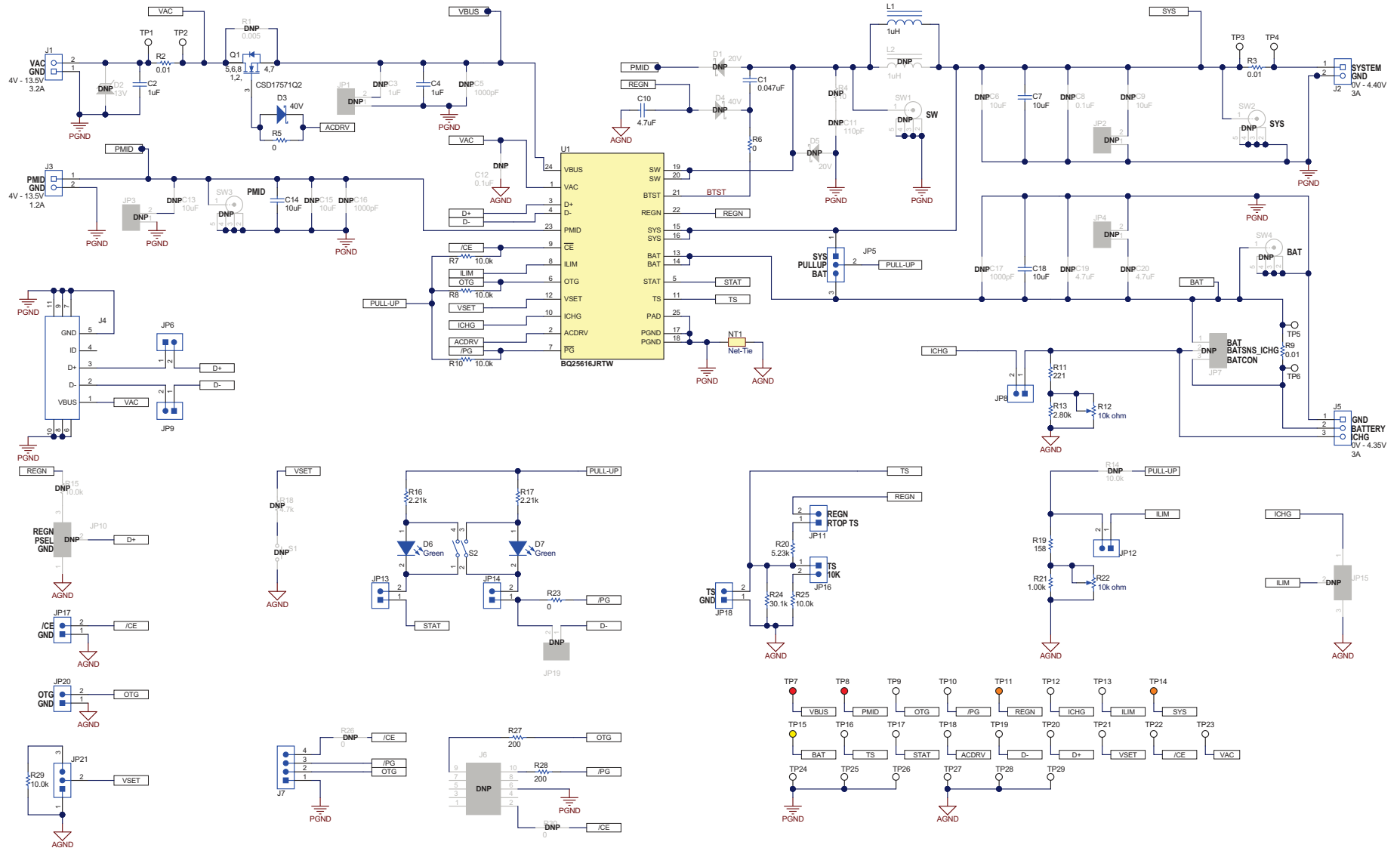


Figure 11. BQ25616JEVM Schematic

6 Bill of Materials

Table 5 lists the BQ25616EVM BOM.

Table 5. BQ25616EVM Bill of Materials

Designator	Quantity	Value	Description	Package Reference	Part Number	Manufacturer	Alternate PartNumber ⁽¹⁾	Alternate Manufacturer ⁽¹⁾
!PCB1	1		Printed Circuit Board		BMS026	Any		
C1	1	0.047μF	CAP, CERM, 0.047 μF, 25 V, +/- 10%, X7R, 0402	0402	GRM155R71E473KA88D	MuRata		
C2	1	1μF	CAP, CERM, 1 μF, 25 V, +/- 10%, X7R, 0805	0805	GRM219R71E105KA88D	MuRata		
C4	1	1μF	CAP, CERM, 1 μF, 35 V, +/- 10%, X5R, 0603	0603	GMK107BJ105KA-T	Taiyo Yuden		
C7	1	10μF	CAP, CERM, 10 μF, 10 V, +/- 10%, X7R, 0805	0805	GRM21BR71A106KA73L	MuRata		
C10	1	4.7μF	CAP, CERM, 4.7 μF, 16 V, +/- 10%, X5R, 0603	0603	GRM188R61C475KAAJD	MuRata		
C14	1	10μF	CAP, CERM, 10 μF, 25 V, +/- 10%, X5R, 0805	0805	GRM21BR61E106KA73L	MuRata		
C18	1	10μF	CAP, CERM, 10 μF, 10 V, +/- 10%, X7R, 0805	0805	GRM21BR71A106KE51L	MuRata		
D3	1	40V	Diode, Schottky, 40 V, 0.38 A, SOD-523	SOD-523	ZLLS350TA	Diodes Inc.		
D6, D7	2	Green	LED, Green, SMD	1.6x0.8x0.8mm	LTST-C190GKT	Lite-On		
H1, H2, H3, H4	4		Bumpon, Hemisphere, 0.44 X 0.20, Clear	Transparent Bumpon	SJ-5303 (CLEAR)	3M		
J1, J2, J3	3		Conn Term Block, 2POS, 3.81mm, TH	2POS Terminal Block	1727010	Phoenix Contact		
J4	1		Connector, Receptacle, Micro-USB Type B, R/A, Bottom Mount SMT	MICRO USB CONN, R/A	1981568-1	TE Connectivity		
J5	1		Terminal Block Receptacle, 3x1, 3.81mm, R/A, TH	Term Block, 3 pos	1727023	Phoenix Contact		
J7	1		Header (friction lock), 100mil, 4x1, R/A, TH	4x1 R/A Header	0022053041	Molex		
JP5, JP21	2		Header, 100mil, 3x1, Tin, TH	Header, 3 PIN, 100mil, Tin	PEC03SAAN	Sullins Connector Solutions		
JP6, JP8, JP9, JP11, JP12, JP13, JP14, JP16, JP17, JP18, JP20	11		Header, 100mil, 2x1, Tin, TH	Header, 2 PIN, 100mil, Tin	PEC02SAAN	Sullins Connector Solutions		

⁽¹⁾ Unless otherwise noted in the Alternate PartNumber and/or Alternate Manufacturer columns, all parts may be substituted with equivalents.

Table 5. BQ25616EVM Bill of Materials (continued)

Designator	Quantity	Value	Description	Package Reference	Part Number	Manufacturer	Alternate PartNumber ⁽¹⁾	Alternate Manufacturer ⁽¹⁾
L1	1	1μH	Inductor, 1 μH, 3.2 A, 0.028 ohm, SMD	2.5x2mm	MPIM252010F1 R0M-LF	Microgate		
LBL1	1		Thermal Transfer Printable Labels, 0.650" W x 0.200" H - 10,000 per roll	PCB Label 0.650 x 0.200 inch	THT-14-423-10	Brady		
Q1	1	30V	MOSFET, N-CH, 30 V, 22 A, DQK0006C (WSON-6)	DQK0006C	CSD17571Q2	Texas Instruments		None
R2, R3, R9	3	0.01	RES, 0.01, 1%, 1 W, 2010	2010	WSL2010R0100 FEA18	Vishay-Dale		
R5, R6, R23	3	0	RES, 0, 5%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW0402000 0Z0ED	Vishay-Dale		
R7, R8, R10, R25, R29	5	10.0k	RES, 10.0 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW040210K 0FKED	Vishay-Dale		
R11	1	221	RES, 221, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW0402221 RFKED	Vishay-Dale		
R12, R22	2	10k ohm	Trimmer, 10k ohm, 0.25W, TH	4.5x8x6.7mm	3266W-1-103LF	Bourns		
R13	1	2.80k	RES, 2.80 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW04022K8 0FKED	Vishay-Dale		
R16, R17	2	2.21k	RES, 2.21 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW04022K2 1FKED	Vishay-Dale		
R19	1	158	RES, 158, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW0402158 RFKED	Vishay-Dale		
R20	1	5.23k	RES, 5.23 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW04025K2 3FKED	Vishay-Dale		
R21	1	1.00k	RES, 1.00 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW04021K0 0FKED	Vishay-Dale		
R24	1	30.1k	RES, 30.1 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW040230K 1FKED	Vishay-Dale		
R27, R28	2	200	RES, 200, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW0402200 RFKED	Vishay-Dale		
S2	1		Switch, SPST, 2 Pos, 25mA, 24VDC, SMD	3.71x5.8mm	218-2LPST	CTS Electrocomponents		
SH-JP5, SH-JP6, SH-JP8, SH-JP9, SH-JP11, SH-JP12, SH-JP13, SH-JP14, SH-JP16, SH-JP17, SH-JP20	11	1x2	Shunt, 100mil, Gold plated, Black	Shunt	SNT-100-BK-G	Samtec	969102-0000-DA	3M

Table 5. BQ25616EVM Bill of Materials (continued)

Designator	Quantity	Value	Description	Package Reference	Part Number	Manufacturer	Alternate PartNumber ⁽¹⁾	Alternate Manufacturer ⁽¹⁾
TP1, TP2, TP3, TP4, TP5, TP6, TP9, TP10, TP12, TP13, TP16, TP17, TP18, TP19, TP20, TP21, TP22, TP23	18		Test Point, Miniature, White, TH	White Miniature Testpoint	5002	Keystone		
TP7, TP8	2		Test Point, Miniature, Red, TH	Red Miniature Testpoint	5000	Keystone		
TP11, TP14	2		Test Point, Miniature, Orange, TH	Orange Miniature Testpoint	5003	Keystone		
TP15	1		Test Point, Miniature, Yellow, TH	Yellow Miniature Testpoint	5004	Keystone		
TP24, TP25, TP26, TP27, TP28, TP29	6		Test Point, Compact, SMT	Testpoint_Keystone_Compact	5016	Keystone		
U1	1		BQ25616RTW, RTW0024P (PVQFN-24)	RTW0024P	BQ25616RTW	Texas Instruments		Texas Instruments
C3	0	1 μ F	CAP, CERM, 1 μ F, 35 V, +/- 10%, X5R, 0603	0603	GMK107BJ105K A-T	Taiyo Yuden		
C5, C16, C17	0	1000pF	CAP, CERM, 1000 pF, 50 V, +/- 5%, C0G/NP0, 0402	0402	GRM1555C1H1 02JA01D	MuRata		
C6, C9	0	10 μ F	CAP, CERM, 10 μ F, 10 V, +/- 10%, X7R, 0805	0805	GRM21BR71A1 06KE51L	MuRata		
C8	0	0.1 μ F	CAP, CERM, 0.1 μ F, 25 V, +/- 20%, X7R, 0402	0402	C1005X7R1E10 4M050BB	TDK		
C11	0	110pF	CAP, CERM, 110 pF, 25 V, +/- 5%, C0G/NP0, 0402	0402	GRM1555C1E1 11JA01D	MuRata		
C12	0	0.1 μ F	CAP, CERM, 0.1 μ F, 25 V, +/- 10%, X7R, 0402	0402	GRM155R71E1 04KE14D	MuRata		
C13	0	10 μ F	CAP, CERM, 10 μ F, 25 V, +/- 10%, X5R, 0805	0805	GRM21BR61E1 06KA73L	MuRata		
C15	0	10 μ F	CAP, CERM, 10 μ F, 25 V, +/- 10%, X7S, 0805	0805	GRM21BC71E1 06KE11L	MuRata		
C19, C20	0	4.7 μ F	CAP, CERM, 4.7 μ F, 16 V, +/- 10%, X5R, 0603	0603	GRM188R61C4 75KAAJ	MuRata		
D1, D5	0	20V	Diode, Schottky, 20 V, 1 A, 152AD	152AD	NSR10F20NXT5 G	ON Semiconductor		

Table 5. BQ25616EVM Bill of Materials (continued)

Designator	Quantity	Value	Description	Package Reference	Part Number	Manufacturer	Alternate PartNumber ⁽¹⁾	Alternate Manufacturer ⁽¹⁾
D2	0	13V	Diode, TVS, Uni, 13 V, 21.5 Vc, SOD-123W	SOD-123W	PTVS13VS1UR, 115	NXP Semiconductor		
D4	0	40V	Diode, Schottky, 40 V, 0.38 A, SOD-523	SOD-523	ZLLS350TA	Diodes Inc.		
FID1, FID2, FID3, FID4, FID5, FID6	0		Fiducial mark. There is nothing to buy or mount.	N/A	N/A	N/A		
J6	0		Header (shrouded), 100mil, 5x2, High-Temperature, Gold, TH	5x2 Shrouded header	N2510-6002-RB	3M		
JP1, JP2, JP3, JP4, JP19	0		Header, 100mil, 2x1, Tin, TH	Header, 2 PIN, 100mil, Tin	PEC02SAAN	Sullins Connector Solutions		
JP7, JP10, JP15	0		Header, 100mil, 3x1, Tin, TH	Header, 3 PIN, 100mil, Tin	PEC03SAAN	Sullins Connector Solutions		
L2	0	1µH	Inductor, Wirewound, 1 µH, 4 A, 0.041 ohm, SMD	4.06x4.06mm	74437321010	Würth Elektronik		
R1	0	0.005	RES, 0.005, 1%, 0.25 W, AEC-Q200 Grade 1, 0603	0603	ERJ3LWFR005 V	Panasonic		
R4	0	10	RES, 10, 5%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW040210R 0JNED	Vishay-Dale		
R14, R15	0	10.0k	RES, 10.0 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW040210K 0FKED	Vishay-Dale		
R18	0	4.7k	RES, 4.7 k, 5%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW04024K7 0JNED	Vishay-Dale		
R26, R30	0	0	RES, 0, 5%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW0402000 0Z0ED	Vishay-Dale		
S1	0		Switch, Normally open, 2.3N force, 200k operations, SMD	KSR	KSR221GLFS	C&K Components		
SH-JP1, SH-JP2, SH-JP3, SH-JP4, SH-JP7, SH-JP10, SH-JP15, SH-JP18, SH-JP19, SH-JP21	0	1x2	Shunt, 100mil, Gold plated, Black	Shunt	SNT-100-BK-G	Samtec	969102-0000-DA	3M
SW1, SW2, SW3, SW4	0		Compact Probe Tip Circuit Board Test Points, TH, 25 per	TH Scope Probe	131-5031-00	Tektronix		

Table 6 lists the BQ25616JEVM BOM.

Table 6. BQ25616JEVM Bill of Materials

Designator	Quantity	Value	Description	Package Reference	Part Number	Manufacturer	Alternate PartNumber ⁽¹⁾	Alternate Manufacturer ⁽¹⁾
!PCB1	1		Printed Circuit Board		BMS026	Any		
C1	1	0.047 μ F	CAP, CERM, 0.047 μ F, 25 V, +/- 10%, X7R, 0402	0402	GRM155R71E473KA88D	MuRata		
C2	1	1 μ F	CAP, CERM, 1 μ F, 25 V, +/- 10%, X7R, 0805	0805	GRM219R71E105KA88D	MuRata		
C4	1	1 μ F	CAP, CERM, 1 μ F, 35 V, +/- 10%, X5R, 0603	0603	GMK107BJ105KA-T	Taiyo Yuden		
C7	1	10 μ F	CAP, CERM, 10 μ F, 10 V, +/- 10%, X7R, 0805	0805	GRM21BR71A106KA73L	MuRata		
C10	1	4.7 μ F	CAP, CERM, 4.7 μ F, 16 V, +/- 10%, X5R, 0603	0603	GRM188R61C475KAAJD	MuRata		
C14	1	10 μ F	CAP, CERM, 10 μ F, 25 V, +/- 10%, X5R, 0805	0805	GRM21BR61E106KA73L	MuRata		
C18	1	10 μ F	CAP, CERM, 10 μ F, 10 V, +/- 10%, X7R, 0805	0805	GRM21BR71A106KE51L	MuRata		
D3	1	40V	Diode, Schottky, 40 V, 0.38 A, SOD-523	SOD-523	ZLLS350TA	Diodes Inc.		
D6, D7	2	Green	LED, Green, SMD	1.6x0.8x0.8mm	LTST-C190GKT	Lite-On		
H1, H2, H3, H4	4		Bumpon, Hemisphere, 0.44 X 0.20, Clear	Transparent Bumpon	SJ-5303 (CLEAR)	3M		
J1, J2, J3	3		Conn Term Block, 2POS, 3.81mm, TH	2POS Terminal Block	1727010	Phoenix Contact		
J4	1		Connector, Receptacle, Micro-USB Type B, R/A, Bottom Mount SMT	MICRO USB CONN, R/A	1981568-1	TE Connectivity		
J5	1		Terminal Block Receptacle, 3x1, 3.81mm, R/A, TH	Term Block, 3 pos	1727023	Phoenix Contact		
J7	1		Header (friction lock), 100mil, 4x1, R/A, TH	4x1 R/A Header	0022053041	Molex		
JP5, JP21	2		Header, 100mil, 3x1, Tin, TH	Header, 3 PIN, 100mil, Tin	PEC03SAAN	Sullins Connector Solutions		
JP6, JP8, JP9, JP11, JP12, JP13, JP14, JP16, JP17, JP18, JP20	11		Header, 100mil, 2x1, Tin, TH	Header, 2 PIN, 100mil, Tin	PEC02SAAN	Sullins Connector Solutions		
L1	1	1 μ H	Inductor, 1 μ H, 3.2 A, 0.028 ohm, SMD	2.5x2mm	MPIM252010F1R0M-LF	Microgate		

⁽¹⁾ Unless otherwise noted in the Alternate PartNumber and/or Alternate Manufacturer columns, all parts may be substituted with equivalents.

Table 6. BQ25616JEVM Bill of Materials (continued)

Designator	Quantity	Value	Description	Package Reference	Part Number	Manufacturer	Alternate PartNumber ⁽¹⁾	Alternate Manufacturer ⁽¹⁾
LBL1	1		Thermal Transfer Printable Labels, 0.650" W x 0.200" H - 10,000 per roll	PCB Label 0.650 x 0.200 inch	THT-14-423-10	Brady		
Q1	1	30V	MOSFET, N-CH, 30 V, 22 A, DQK0006C (WSON-6)	DQK0006C	CSD17571Q2	Texas Instruments		None
R2, R3, R9	3	0.01	RES, 0.01, 1%, 1 W, 2010	2010	WSL2010R0100 FEA18	Vishay-Dale		
R5, R6, R23	3	0	RES, 0, 5%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW0402000 0Z0ED	Vishay-Dale		
R7, R8, R10, R25, R29	5	10.0k	RES, 10.0 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW040210K 0FKED	Vishay-Dale		
R11	1	221	RES, 221, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW0402221 RFKED	Vishay-Dale		
R12, R22	2	10k ohm	Trimmer, 10k ohm, 0.25W, TH	4.5x8x6.7mm	3266W-1-103LF	Bourns		
R13	1	2.80k	RES, 2.80 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW04022K8 0FKED	Vishay-Dale		
R16, R17	2	2.21k	RES, 2.21 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW04022K2 1FKED	Vishay-Dale		
R19	1	158	RES, 158, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW0402158 RFKED	Vishay-Dale		
R20	1	5.23k	RES, 5.23 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW04025K2 3FKED	Vishay-Dale		
R21	1	1.00k	RES, 1.00 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW04021K0 0FKED	Vishay-Dale		
R24	1	30.1k	RES, 30.1 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW040230K 1FKED	Vishay-Dale		
R27, R28	2	200	RES, 200, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW0402200 RFKED	Vishay-Dale		
S2	1		Switch, SPST, 2 Pos, 25mA, 24VDC, SMD	3.71x5.8mm	218-2LPST	CTS Electrocompon ents		
SH-JP5, SH- JP6, SH-JP8, SH-JP9, SH- JP11, SH-JP12, SH-JP13, SH- JP14, SH-JP16, SH-JP17, SH- JP20	11	1x2	Shunt, 100mil, Gold plated, Black	Shunt	SNT-100-BK-G	Samtec	969102-0000- DA	3M

Table 6. BQ25616JEVM Bill of Materials (continued)

Designator	Quantity	Value	Description	Package Reference	Part Number	Manufacturer	Alternate PartNumber ⁽¹⁾	Alternate Manufacturer ⁽¹⁾
TP1, TP2, TP3, TP4, TP5, TP6, TP9, TP10, TP12, TP13, TP16, TP17, TP18, TP19, TP20, TP21, TP22, TP23	18		Test Point, Miniature, White, TH	White Miniature Testpoint	5002	Keystone		
TP7, TP8	2		Test Point, Miniature, Red, TH	Red Miniature Testpoint	5000	Keystone		
TP11, TP14	2		Test Point, Miniature, Orange, TH	Orange Miniature Testpoint	5003	Keystone		
TP15	1		Test Point, Miniature, Yellow, TH	Yellow Miniature Testpoint	5004	Keystone		
TP24, TP25, TP26, TP27, TP28, TP29	6		Test Point, Compact, SMT	Testpoint_Keystone_Compact	5016	Keystone		
U1	1		BQ25616JRTW, RTW0024P (PVQFN-24)	RTW0024P	BQ25616JRTW	Texas Instruments		Texas Instruments
C3	0	1 μ F	CAP, CERM, 1 μ F, 35 V, +/- 10%, X5R, 0603	0603	GMK107BJ105K A-T	Taiyo Yuden		
C5, C16, C17	0	1000pF	CAP, CERM, 1000 pF, 50 V, +/- 5%, C0G/NP0, 0402	0402	GRM1555C1H1 02JA01D	MuRata		
C6, C9	0	10 μ F	CAP, CERM, 10 μ F, 10 V, +/- 10%, X7R, 0805	0805	GRM21BR71A1 06KE51L	MuRata		
C8	0	0.1 μ F	CAP, CERM, 0.1 μ F, 25 V, +/- 20%, X7R, 0402	0402	C1005X7R1E10 4M050BB	TDK		
C11	0	110pF	CAP, CERM, 110 pF, 25 V, +/- 5%, C0G/NP0, 0402	0402	GRM1555C1E1 11JA01D	MuRata		
C12	0	0.1 μ F	CAP, CERM, 0.1 μ F, 25 V, +/- 10%, X7R, 0402	0402	GRM155R71E1 04KE14D	MuRata		
C13	0	10 μ F	CAP, CERM, 10 μ F, 25 V, +/- 10%, X5R, 0805	0805	GRM21BR61E1 06KA73L	MuRata		
C15	0	10 μ F	CAP, CERM, 10 μ F, 25 V, +/- 10%, X7S, 0805	0805	GRM21BC71E1 06KE11L	MuRata		
C19, C20	0	4.7 μ F	CAP, CERM, 4.7 μ F, 16 V, +/- 10%, X5R, 0603	0603	GRM188R61C4 75KAAJ	MuRata		
D1, D5	0	20V	Diode, Schottky, 20 V, 1 A, 152AD	152AD	NSR10F20NXT5 G	ON Semiconductor		

Table 6. BQ25616JEVM Bill of Materials (continued)

Designator	Quantity	Value	Description	Package Reference	Part Number	Manufacturer	Alternate PartNumber ⁽¹⁾	Alternate Manufacturer ⁽¹⁾
D2	0	13V	Diode, TVS, Uni, 13 V, 21.5 Vc, SOD-123W	SOD-123W	PTVS13VS1UR, 115	NXP Semiconductor		
D4	0	40V	Diode, Schottky, 40 V, 0.38 A, SOD-523	SOD-523	ZLLS350TA	Diodes Inc.		
FID1, FID2, FID3, FID4, FID5, FID6	0		Fiducial mark. There is nothing to buy or mount.	N/A	N/A	N/A		
J6	0		Header (shrouded), 100mil, 5x2, High-Temperature, Gold, TH	5x2 Shrouded header	N2510-6002-RB	3M		
JP1, JP2, JP3, JP4, JP19	0		Header, 100mil, 2x1, Tin, TH	Header, 2 PIN, 100mil, Tin	PEC02SAAN	Sullins Connector Solutions		
JP7, JP10, JP15	0		Header, 100mil, 3x1, Tin, TH	Header, 3 PIN, 100mil, Tin	PEC03SAAN	Sullins Connector Solutions		
L2	0	1µH	Inductor, Wirewound, 1 µH, 4 A, 0.041 ohm, SMD	4.06x4.06mm	74437321010	Würth Elektronik		
R1	0	0.005	RES, 0.005, 1%, 0.25 W, AEC-Q200 Grade 1, 0603	0603	ERJ3LWFR005 V	Panasonic		
R4	0	10	RES, 10, 5%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW040210R 0JNED	Vishay-Dale		
R14, R15	0	10.0k	RES, 10.0 k, 1%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW040210K 0FKED	Vishay-Dale		
R18	0	4.7k	RES, 4.7 k, 5%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW04024K7 0JNED	Vishay-Dale		
R26, R30	0	0	RES, 0, 5%, 0.063 W, AEC-Q200 Grade 0, 0402	0402	CRCW0402000 0Z0ED	Vishay-Dale		
S1	0		Switch, Normally open, 2.3N force, 200k operations, SMD	KSR	KSR221GLFS	C&K Components		
SH-JP1, SH-JP2, SH-JP3, SH-JP4, SH-JP7, SH-JP10, SH-JP15, SH-JP18, SH-JP19, SH-JP21	0	1x2	Shunt, 100mil, Gold plated, Black	Shunt	SNT-100-BK-G	Samtec	969102-0000-DA	3M
SW1, SW2, SW3, SW4	0		Compact Probe Tip Circuit Board Test Points, TH, 25 per	TH Scope Probe	131-5031-00	Tektronix		

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